# TEST REPORT

**FCT**通测检测 TESTING CENTRE TECHNOLOGY

> FCC ID:2AG3PCQL1554-B Product: Bluetooth Speaker Model No.: CQL1554-B Additional Model: OPT, SP3133 Trade Mark: SURE Report No.: TCT160617E001 Issued Date: Jun. 28, 2016

#### Issued for:

Conquer (China) Industry Co., Ltd A-703, Building 2, Tianan Cyber Park, HuangGe North Road, LongGang District, Shenzhen 518172, P.R. China.

Issued By:

Shenzhen Tongce Testing Lab. 1F, Leinuo Watch Building, Fuyong Town, Baoan Dist, Shenzhen, China TEL: +86-755-27673339 FAX: +86-755-27673332

**Note:** This report shall not be reproduced except in full, without the written approval of Shenzhen Tongce Testing Lab. This document may be altered or revised by Shenzhen Tongce Testing Lab. personnel only, and shall be noted in the revision section of the document. The test results in the report only apply to the tested sample.

# TABLE OF CONTENTS

TCT通测检测 TESTING CENTRE TECHNOLOGY

	Test Certification	
2.	Test Result Summary	
3.	EUT Description	
4.	Genera Information	6
	4.1. Test environment and mode	6
	4.2. Description of Support Units	6
5.	Facilities and Accreditations	
	5.1. Facilities	
	5.2. Location	7
	5.3. Measurement Uncertainty	7
6.	Test Results and Measurement Data	
	6.1. Antenna requirement	
	6.2. Conducted Emission	
	6.3. Conducted Output Power	13
	6.4. 20dB Occupy Bandwidth	
	6.5. Carrier Frequencies Separation	
	6.6. Hopping Channel Number	
	6.7. Dwell Time	
	6.8. Pseudorandom Frequency Hopping Sequence	
	6.9. Conducted Band Edge Measurement	
	6.10. Conducted Spurious Emission Measurement	
	6.11. Radiated Spurious Emission Measurement	21
Ap	opendix A: Test Result of Conducted Test	
Ap	opendix B: Photographs of Test Setup	
Ap	opendix C: Photographs of EUT.	
-		



# 1. Test Certification

Product:	Bluetooth Speaker		
Model No.:	CQL1554-B	)	(ć
Additional Model:	OPT, SP3133	/	C
Applicant:	Conquer (China) Industry Co., Ltd	$(\mathbf{c})$	
Address:	A-703, Building 2, Tianan Cyber Park, HuangGe N LongGang District, Shenzhen 518172, P.R. China		
Manufacturer:	Conquer (China) Industry Co., Ltd	)	
Address:	A-703, Building 2, Tianan Cyber Park, HuangGe N LongGang District, Shenzhen 518172, P.R. China	•	
Date of Test:	Jun. 17 – Jun. 27, 2016	S S	
Applicable Standards:	FCC CFR Title 47 Part 15 Subpart C Section 15.2	47	G
		)	K

The above equipment has been tested by Shenzhen Tongce Testing Lab. and found compliance with the requirements set forth in the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

	Tested By:	SKY Luo	Date:	Jun. 27, 2016	
	Reviewed By:	Joe Zhou	Date:	Jun. 28, 2016	
	Approved By:	Tomsin	Date:	Jun. 28, 2016	
Hotlin	e: 400-6611-140 Tel:	86-755-27673339 Fax	: 86-755-276733		e 3 of 67



# 2. Test Result Summary

Requirement	CFR 47 Section		Result
Antenna Requirement	§15.203/§15.247 (c)	KD -	PASS
AC Power Line Conducted Emission	§15.207		PASS
Conducted Peak Output Power	§15.247 (b)(1) §2.1046		PASS
20dB Occupied Bandwidth	§15.247 (a)(1) §2.1049		PASS
Carrier Frequencies Separation	§15.247 (a)(1)		PASS
Hopping Channel Number	§15.247 (a)(1)		PASS
Dwell Time	§15.247 (a)(1)		PASS
Radiated Emission	§15.205/§15.209 §2.1053, §2.1057		PASS
Band Edge	§15.247(d) §2.1051, §2.1057		PASS
lote: 1. PASS: Test item meets the require	ement.		
2. Fail: Test item does not meet the	requirement.		

4. The test result judgment is decided by the limit of test standard.

# 3. EUT Description

Product Name:	Bluetooth Speaker
Model :	CQL1554-B
Additional Model:	OPT, SP3133
Trade Mark:	SURE
<b>Operation Frequency:</b>	2402MHz~2480MHz
Transfer Rate:	1/2 Mbits/s
Number of Channel:	79
Modulation Type:	GFSK, π/4-DQPSK
Modulation Technology:	FHSS
Antenna Type:	Internal Antenna
Antenna Gain:	0dBi
Power Supply:	Rechargeable Li-ion Battery DC3.7V
Remark:	All models above are identical in interior structure, electrical circuits and components, and just model names are different for the marketing requirement.

# Operation Frequency each of channel for GFSK, $\pi/4$ -DQPSK

Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
<b>G</b> )0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz 🔾
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
18	2420MHz	38	2440MHz	58	2460MHz	- 78	2480MHz
19	2421MHz	39	2441MHz	59	2461MHz		-
Remark:	Channel 0, 3	9 &78 ha	ve been tes	ted for GI		<b>PSK</b> mo	dulation mode.



# 4. Genera Information

# 4.1. Test environment and mode

Operating Environment:	
Temperature:	25.0 °C
Humidity:	56 % RH
Atmospheric Pressure:	1010 mbar
Test Mode:	
Engineering mode:	Keep the EUT in continuous transmitting

by select channel and modulations The sample was placed 0.8m & 1.5m for the measurement below & above 1GHz above the ground plane of 3m chamber. Measurements in both horizontal and vertical polarities were performed. During the test, each emission was maximized by: having the EUT continuously working, investigated all operating modes, rotated about all 3

axis (X, Y & Z) and considered typical configuration to obtain worst position, manipulating interconnecting cables, rotating the turntable, varying antenna height from 1m to 4m in both horizontal and vertical polarizations. The emissions worst-case are shown in Test Results of the following pages.

# 4.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
1	Ι	<u>ح)</u> ۱	G) 1	

Note:

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.
- 3. For conducted measurements (Output Power, 20dB Occupied Bandwidth, Carrier Frequencies Separation, Hopping Channel Number, Dwell Time, Spurious Emissions), the antenna of EUT is connected to the test equipment via temporary antenna connector, the antenna connector is soldered on the antenna port of EUT, and the temporary antenna connector is listed in the Test Instruments.



# 5. Facilities and Accreditations

# 5.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

- FCC Registration No.: 572331
  - Shenzhen Tongce Testing Lab

The 3m Semi-anechoic chamber has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

• IC - Registration No.: 10668A-1

The 3m Semi-anechoic chamber of Shenzhen TCT Testing Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing

• CNAS - Registration No.: CNAS L6165

Shenzhen TCT Testing Technology Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6165.

# 5.2. Location

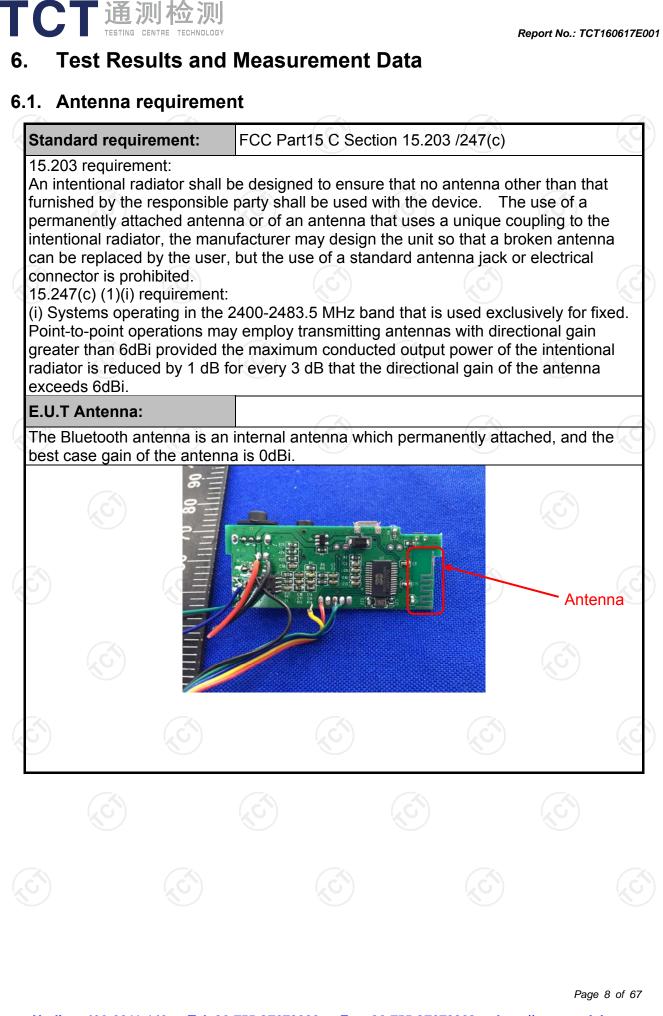
Shenzhen Tongce Testing Lab

Address: 1F, Leinuo Watch Building, Fuyong Town, Baoan Dist, Shenzhen, China Tel: 86-755-36638142

# 5.3. Measurement Uncertainty

The reported uncertainty of measurement  $y \pm U$ , where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

No.	Item	MU
1	Conducted Emission	±2.56dB
2	RF power, conducted	±0.12dB
3	Spurious emissions, conducted	±0.11dB
4	All emissions, radiated(<1G)	±3.92dB
5	All emissions, radiated(>1G)	±4.28dB
6	Temperature	±0.1°C
7	Humidity	±1.0%



Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com



# 6.2. Conducted Emission

#### 6.2.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.207					
Test Method:	ANSI C63.10:2013					
Frequency Range:	150 kHz to 30 MHz	<b>(()</b>				
Receiver setup:	RBW=9 kHz, VBW=30	kHz, Sweep time	=auto			
	Frequency range	Limit (	dBuV)			
	(MHz)	Quasi-peak	Áverage			
Limits:	0.15-0.5	66 to 56*	56 to 46*			
	0.5-5	56	46			
	5-30	60	50			
	Referenc	e Plane				
Test Setup:	E.U.T AC powe	EMI Receiver	— AC power			
	Remark: E.U.T: Equipment Under Test LISN: Line Impedence Stabilization N Test table height=0.8m	etwork				
Test Mode:	E.U.T: Equipment Under Test LISN: Line Impedence Stabilization N Test table height=0.8m Refer to item 4.1					
	<ul> <li>E.U.T. Equipment Under Test LISN Line Impedence Stabilization Na Test table height=0.8m</li> <li>Refer to item 4.1</li> <li>1. The E.U.T and simulation power through a line (L.I.S.N.). This pro- impedance for the minimpedance for the minimpedance for the minimpedance for the minimpedance power through a Line coupling impedance refer to the block photographs).</li> <li>3. Both sides of A.C. conducted interferent emission, the relative the interface cables</li> </ul>	ulators are connect e impedance stab ovides a 500hm neasuring equipme ces are also connect SN that provides e with 500hm term diagram of the line are checked nce. In order to fin e positions of equipment s must be chang	bilization networ /50uH couplin ent. ected to the main a 50ohm/50uh nination. (Pleas test setup and ed for maximum ind the maximum ipment and all of ied according to the maximum test setup and the maximum the the maximum the maximum the maximum the maximum the maximum the maximum the the maximum the the maximum the maximum the the the the the the the the the the			
Test Mode: Test Procedure: Test Result:	<ul> <li>E.U.T. Equipment Under Test LISN Line Impedence Stabilization Na Test table height=0.8m</li> <li>Refer to item 4.1</li> <li>1. The E.U.T and simulation power through a line (L.I.S.N.). This pro- impedance for the minimal 2. The peripheral device power through a Line coupling impedance refer to the block photographs).</li> <li>3. Both sides of A.C. conducted interferent emission, the relative</li> </ul>	ulators are connect e impedance stab ovides a 500hm neasuring equipme ces are also connect SN that provides e with 500hm term diagram of the line are checked nce. In order to fin e positions of equipment s must be chang	bilization networ /50uH couplin ent. ected to the main a 50ohm/50ul nination. (Pleas test setup an ed for maximur ind the maximur ipment and all of ied according t			

#### 6.2.2. Test Instruments

Conducted Emission Shielding Room Test Site (843)									
Equipment	Manufacturer	Model	Serial Number	Calibration Due					
EMI Test Receiver	R&S	ESCS30	100139	Sep. 11, 2016					
LISN	Schwarzbeck	NSLK 8126	8126453	Sep. 16, 2016					
Coax cable	тст	CE-05	N/A	Sep. 11, 2016					
EMI Test Software	Shurple Technology	EZ-EMC	N/A	N/A					

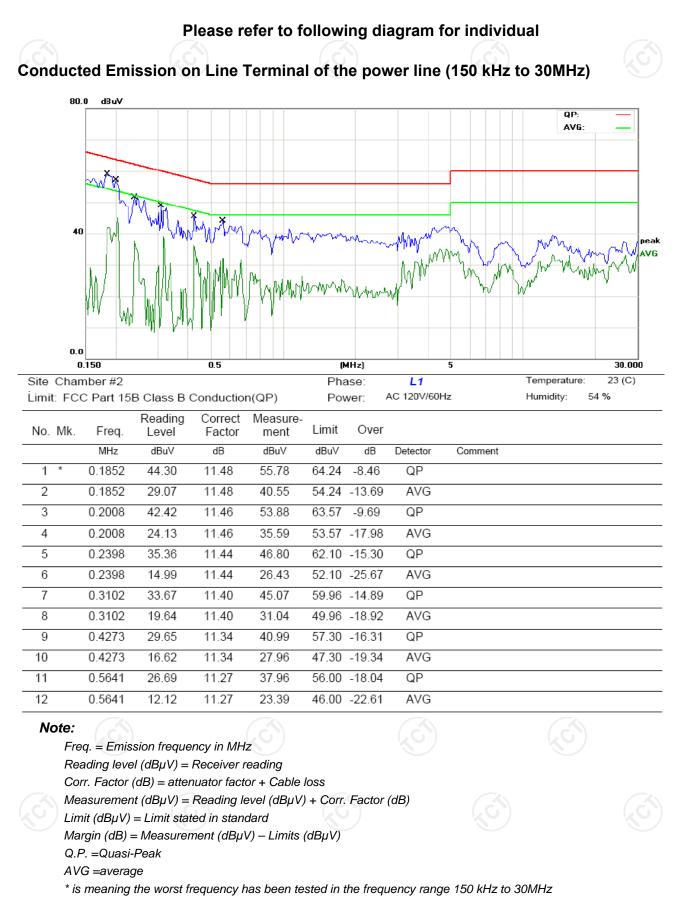
**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 10 of 67

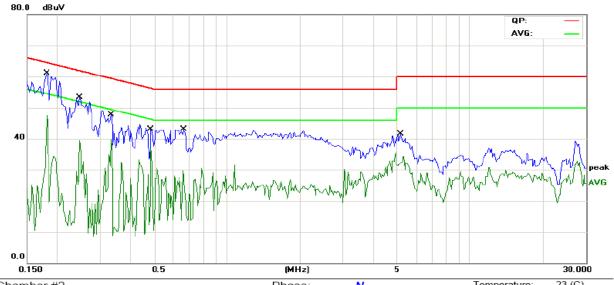
Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com

#### 6.2.3. Test data

TCT 通测检测 TESTING CENTRE TECHNOLOGY



Report No.: TCT160617E001



#### Conducted Emission on Neutral Terminal of the power line (150 kHz to 30MHz)

Site Chamber #2Phase:NTemperature:23 (C)Limit: FCC Part 15B Class B Conduction(QP)Power:AC 120V/60HzHumidity:54 %

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	*	0.1812	46.41	11.50	57.91	64.43	-6.52	QP	
2		0.1812	26.87	11.50	38.37	54.43	-16.06	AVG	
3		0.2477	38.91	11.46	50.37	61.83	-11.46	QP	
4		0.2477	21.28	11.46	32.74	51.83	-19.09	AVG	
5		0.3336	31.81	11.41	43.22	59.36	-16.14	QP	
6		0.3336	12.78	11.41	24.19	49.36	-25.17	AVG	
7		0.4859	26.46	11.32	37.78	56.24	-18.46	QP	
8		0.4859	10.13	11.32	21.45	46.24	-24.79	AVG	
9		0.6617	28.06	11.24	39.30	56.00	-16.70	QP	
10		0.6617	13.18	11.24	24.42	46.00	-21.58	AVG	
11		5.1719	25.11	10.65	35.76	60.00	-24.24	QP	
12		5.1719	14.81	10.65	25.46	50.00	-24.54	AVG	

#### Note1:

Freq. = Emission frequency in MHz Reading level  $(dB\mu V)$  = Receiver reading Corr. Factor (dB) = attenuator factor + Cable loss Measurement  $(dB\mu V)$  = Reading level  $(dB\mu V)$  + Corr. Factor (dB)Limit  $(dB\mu V)$  = Limit stated in standard Margin (dB) = Measurement  $(dB\mu V)$  – Limits  $(dB\mu V)$ Q.P. =Quasi-Peak AVG =average

\* is meaning the worst frequency has been tested in the frequency range 150 kHz to 30MHz.

#### Note2:

Measurements were conducted in all three channels (high, middle, low) and three modulation (GFSK, Pi/4 DQPSK), and the worst case Mode (Lowest channel and GFSK) was submitted only.



# 6.3. Conducted Output Power

### 6.3.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (b)(3)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	Section 15.247 (b) The maximum peak conducted output power of the intentional radiator shall not exceed the following: (1) For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band 0.125 watts.
Test Setup:	
Test Mode:	Spectrum Analyzer         EUT           Transmitting mode with modulation         C
Test Procedure:	Use the following spectrum analyzer settings: Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel RBW > the 20 dB bandwidth of the emission being measured VBW ≥ RBW Sweep = auto Detector function = peak Trace = max hold Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission.
Test Result:	PASS

#### 6.3.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016
RF Cable	тст	RE-06	N/A	Sep. 12, 2016
Antenna Connector	ТСТ	RFC-01	N/A	Sep. 12, 2016

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 13 of 67



# 6.4. 20dB Occupy Bandwidth

### 6.4.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	N/A
Test Setup:	
Test Mode:	Spectrum Analyzer         EUT           Transmitting mode with modulation         Transmitting mode with modulation
Test Procedure:	<ol> <li>The testing follows FCC Public Notice DA 00-705 Measurement Guidelines.</li> <li>The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.</li> <li>Set to the maximum power setting and enable the EUT transmit continuously.</li> <li>Use the following spectrum analyzer settings for 20dB Bandwidth measurement. Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel; RBW≥1% of the 20 dB bandwidth; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold.</li> <li>Measure and record the results in the test report.</li> </ol>
Test Result:	PASS

#### 6.4.2. Test Instruments

RF Test Room				
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016
RF cable	тст	RE-06	N/A	Sep. 12, 2016
Antenna Connector	🖒 тст	RFC-01	N/A	Sep. 12, 2016

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).





# 6.5. Carrier Frequencies Separation

#### 6.5.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	Frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater.
Test Setup:	Spectrum Analyzer
Test Mode:	Hopping mode
Test Procedure:	<ol> <li>The testing follows FCC Public Notice DA 00-705 Measurement Guidelines.</li> <li>The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.</li> <li>Set to the maximum power setting and enable the EUT transmit continuously.</li> <li>Enable the EUT hopping function.</li> <li>Use the following spectrum analyzer settings: Span = wide enough to capture the peaks of two adjacent channels; RBW≥1% of the span; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold.</li> <li>Measure and record the results in the test report.</li> </ol>
Test Result:	PASS

## 6.5.2. Test Instruments

RF Test Room				
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016
RF cable	тст	RE-06	N/A	Sep. 12, 2016
Antenna Connector	🕑 тст	RFC-01	N/A	Sep. 12, 2016

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 15 of 67



# 6.6. Hopping Channel Number

### 6.6.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.
Test Setup:	
	Spectrum Analyzer EUT
Test Mode:	Hopping mode
Test Procedure:	<ol> <li>The testing follows FCC Public Notice DA 00-705 Measurement Guidelines.</li> <li>The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.</li> <li>Set to the maximum power setting and enable the EUT transmit continuously.</li> <li>Enable the EUT hopping function.</li> <li>Use the following spectrum analyzer settings: Span = the frequency band of operation; RBW ≥1% of the span; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold.</li> <li>The number of hopping frequency used is defined as the number of total channel.</li> <li>Record the measurement data derived from spectrum analyzer.</li> </ol>
Test Result:	PASS

#### 6.6.2. Test Instruments

	RF Test Room			
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016
RF cable	тст	RE-06	N/A	Sep. 12, 2016
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 16 of 67

RF Test Room				
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016
RF cable	тст	RE-06	N/A	Sep. 12, 2016
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 17 of 67

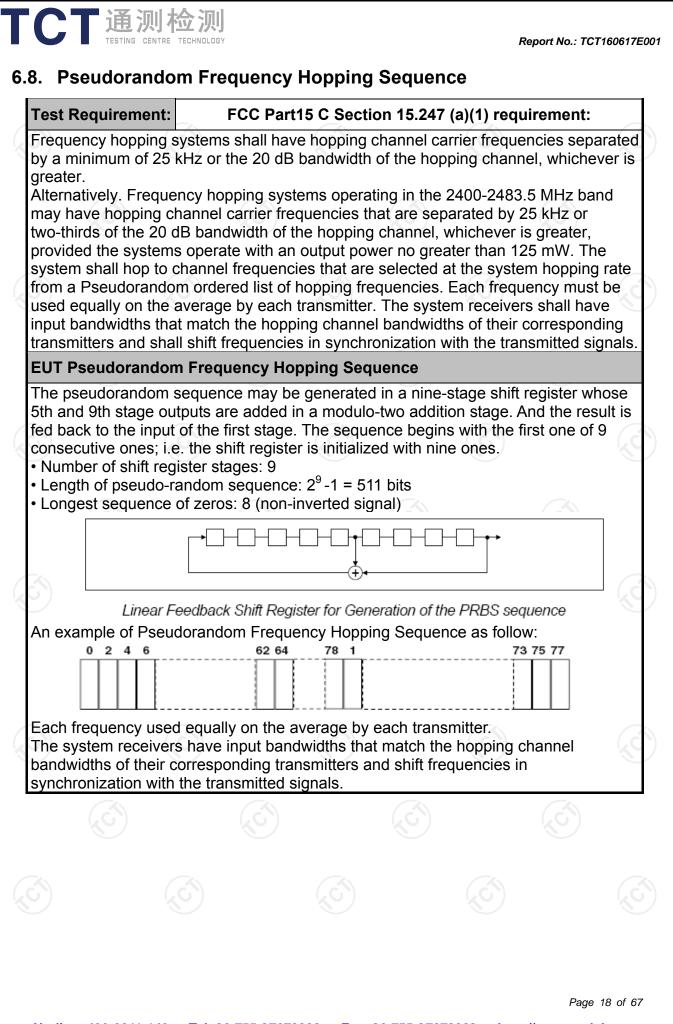
# 6.7. Dwell Time

# 6.7.1. Test Specification

TCT 通测检测 TESTING CENTRE TECHNOLOGY

Test Requirement:	FCC Part15 C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.
Test Setup:	
	Spectrum Analyzer
Test Mode:	Hopping mode
Test Procedure:	<ol> <li>The testing follows FCC Public Notice DA 00-705 Measurement Guidelines.</li> <li>The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.</li> <li>Set to the maximum power setting and enable the EUT transmit continuously.</li> <li>Enable the EUT hopping function.</li> <li>Use the following spectrum analyzer settings: Span = zero span, centered on a hopping channel; RBW = 1 MHz; VBW≥RBW; Sweep = as necessary to capture the entire dwell time per hopping channel; Detector function = peak; Trace = max hold.</li> <li>Measure and record the results in the test report.</li> </ol>
Test Result:	PASS

Report No.: TCT160617E001



Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com

# TCT通测检测 6.9. Conducted Band Edge Measurement

# 6.9.1. Test Specification

FCC Part15 C Section 15.247 (d)
ANSI C63.10:2013 and DA00-705
In any 100 kHz bandwidth outside the intentional radiation frequency band, the radio frequency power shall be at least 20 dB below the highest level of the radiated power. In addition, radiated emissions which fal in the restricted bands must also comply with the radiated emission limits.
Spectrum Analyzer
Transmitting mode with modulation
<ol> <li>The testing follows the guidelines in Band-edge Compliance of RF Conducted Emissions of FCC Public Notice DA 00-705 Measurement Guidelines.</li> <li>Set to the maximum power setting and enable the EUT transmit continuously.</li> <li>Set RBW = 100 kHz (≥1% span=10MHz), VBW = 300 kHz (≥RBW). Band edge emissions must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100kHz RBW. The attenuation shall be 30 dB instead of 20 dB when RMS conducted output power procedure is used.</li> <li>Enable hopping function of the EUT and then repeat step 2 and 3.</li> <li>Measure and record the results in the test report.</li> </ol>
PASS

# 6.9.2. Test Instruments

RF Test Room								
Equipment	Manufacturer	Model	Serial Number	Calibration Due				
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016				
RF cable	🕥 тст	RE-06	N/A	Sep. 12, 2016				
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016				

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 19 of 67



# 6.10. Conducted Spurious Emission Measurement

#### 6.10.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (d)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	In any 100 kHz bandwidth outside the intentional radiation frequency band, the radio frequency power shall be at least 20 dB below the highest level of the radiated power. In addition, radiated emissions which fall in the restricted bands must also comply with the radiated emission limits.
Test Setup:	Spectrum Analyzer EUT
Test Mode:	Transmitting mode with modulation
Test Procedure:	<ol> <li>The testing follows the guidelines in Spurious RF Conducted Emissions of FCC Public Notice DA 00-705 Measurement Guidelines</li> <li>The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.</li> <li>Set to the maximum power setting and enable the EUT transmit continuously.</li> <li>Set RBW = 100 kHz, VBW = 300kHz, scan up through 10th harmonic. All harmonics / spurs must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100 kHz RBW.</li> <li>Measure and record the results in the test report.</li> <li>The RF fundamental frequency should be excluded against the limit line in the operating frequency band.</li> </ol>
Test Result:	PASS
GI) (GI)	

## 6.10.2. Test Instruments

RF Test Room									
Equipment	Manufacturer	Model	Serial Number	Calibration Due					
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016					
RF cable	су тст	RE-06	N/A	Sep. 12, 2016					
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016					

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Page 20 of 67



# 6.11. Radiated Spurious Emission Measurement

#### 6.11.1. Test Specification

TCT通测检测 TESTING CENTRE TECHNOLOGY

Test Requirement:	FCC Part15	C Section	15.209			No.
Test Method:	ANSI C63.10: 2013					
Frequency Range:	9 kHz to 25 (	GHz				
Measurement Distance:	3 m	X	9		R	)
Antenna Polarization:	Horizontal & Vertical					
	Frequency	Detector	RBW	VBW		Remark
	9kHz- 150kHz	Quasi-peak	200Hz	1kHz		si-peak Value
Receiver Setup:	150kHz- 30MHz	Quasi-peak	s 9kHz	30kHz	Quas	si-peak Value
·	30MHz-1GHz	Quasi-peak	100KHz	300KHz	Quas	si-peak Value
	Above 1GHz	Peak	1MHz	3MHz		eak Value
		Peak	1MHz	10Hz	Ave	erage Value
	-		Field Str	ength	Me	asurement
	Frequen	псу	(microvolts	-		nce (meters)
	0.009-0.4		2400/F(			300
	0.490-1.7		24000/F	(KHz)		30
	1.705-30		30		30	
	30-88		100		3	
Limit:	216-96	1 / ·	200		3	
	Above 960		500		3	
	Frequency Above 1GHz	(micro	bisite         Dista           500         3           5000         3		Average	
Test setup:	EUT	ssions below istance = 3m Turn table			Compu	
5)		Ĵ)	(,	S		

Antenna Tower Search Antenna RF T est Receiver HZ HTZ Horn Antenna Tower HTZ Horn Antenna Tower HTZ Horn Antenna Tower Horn Antenna Tower HTZ Horn Antenna Tower HTZ Horn Antenna Tower Horn Antenna Tower HTZ Horn Antenna Tower HTZ HTT HOR Antenna Tower HTZ HTT HTT HOR Antenna Tower HTZ HTT HOR ANTENNA HTZ HTT HOR ANTENNA HTZ HOR ANTENNA HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HTZ HOR ANTENNA HOR ANT
Hz
Test Receiver
itting mode with modulation
e testing follows the guidelines in Spurious diated Emissions of FCC Public Notice DA 705 Measurement Guidelines. the radiated emission test below 1GHz: EUT was placed on a turntable with 0.8 meter ve ground. The EUT was set 3 meters from the ference receiving antenna, which was mounted he top of a variable height antenna tower. The T was arranged to its worst case and then tune antenna tower (from 1 m to 4 m) and turntable m 0 degree to 360 degrees) to find the maximum ding. A pre-amp and a high PASS filter are used he test in order to get better signal level. the radiated emission test above 1GHz: the measurement antenna on a turntable with meter above ground, which is away from each a of the EUT determined to be a source of ssions at the specified measurement distance, e keeping the measurement antenna aimed at source of emissions at each frequency of ificant emissions, with polarization oriented for timum response. The measurement antenna

			liation pattern of the er	
	re m ar ar at 3. S	ceiving the maximule easurement antenn aximizes the emiss ntenna elevation for estricted to a range pove the ground or set to the maximum UT transmit continu	ha elevation shall be the ions. The measurement maximum emissions and of heights of from 1 me reference ground plane in power setting and en uously.	at which nt shall be to 4 m e. nable the
	(	<ol> <li>Span shall wide emission being r</li> <li>Set RBW=100 k for f&gt;1GHz ; VBV Sweep = auto; = max hold for r</li> <li>For average me correction factor</li> </ol>	Hz for f < 1 GHz, RBW W≥RBW; Detector function = pea peak easurement: use duty o r method per	e the /=1MHz ak; Trace cycle
	3	On time =N1*L1 Where N1 is nu length of type 1 Average Emiss Level + 20*log(	ion Level = Peak Emis Duty cycle)	1+Nn*Ln L1 is sion
Test	DAGO	Loss + Read Lev	ng: Antenna Factor + ( vel - Preamp Factor = I	
Test results:	PASS			



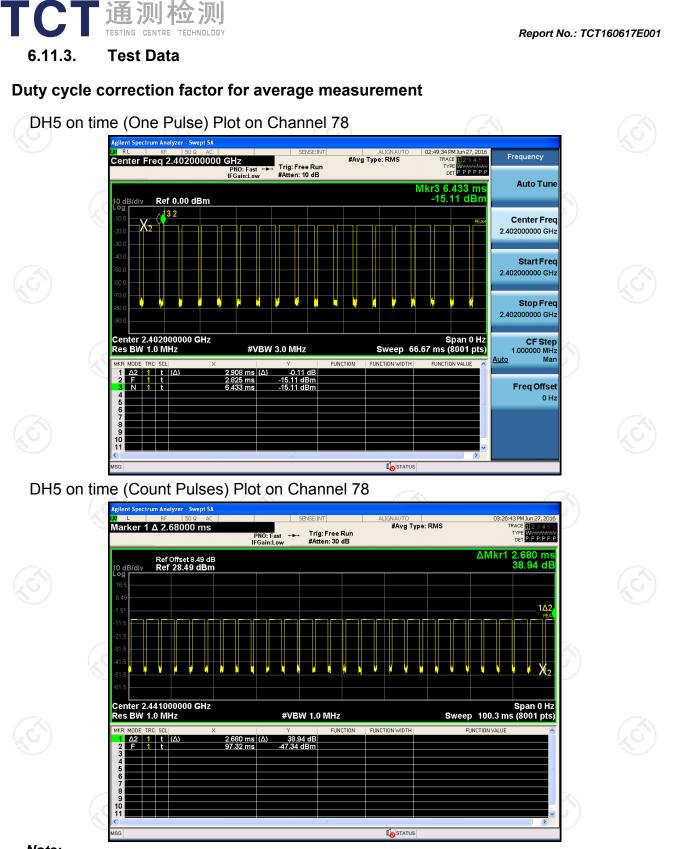


## 6.11.2. Test Instruments

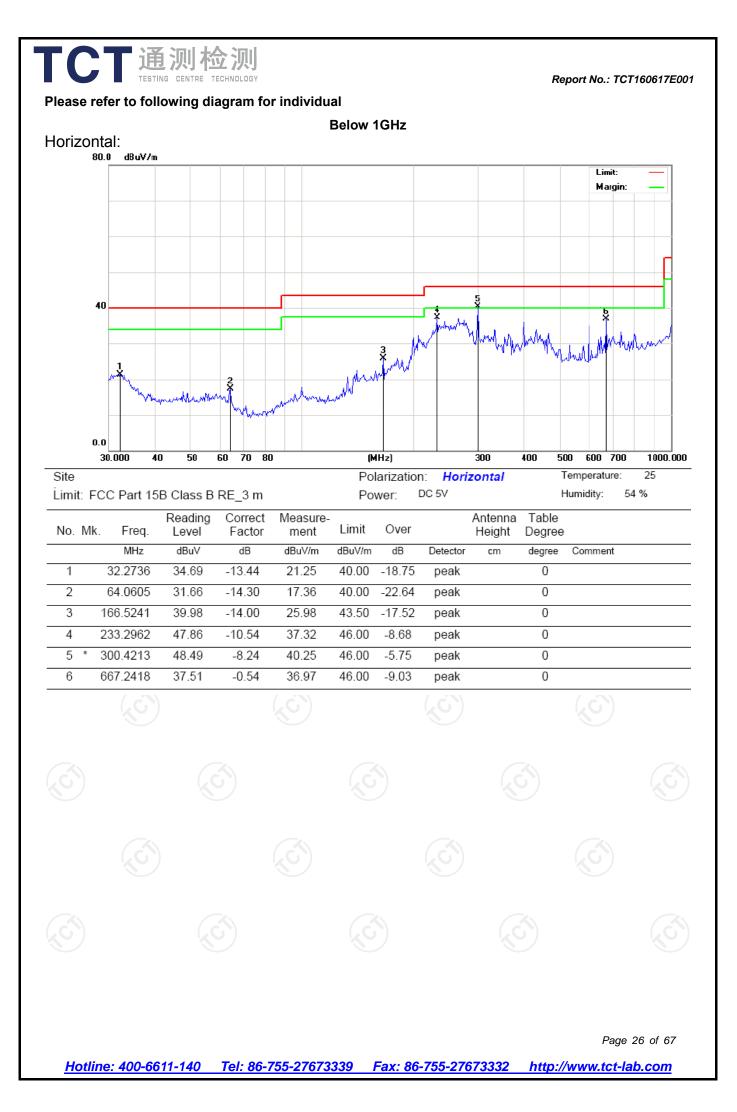
Radiated Emission Test Site (966)								
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due				
ESPI Test Receiver	ROHDE&SCHW ARZ	ESVD	100008	Sep. 11, 2016				
Spectrum Analyzer	ROHDE&SCHW ARZ	FSEM	848597/001	Sep. 11, 2016				
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016				
Pre-amplifier	EM Electronics Corporation CO.,LTD	EM30265	07032613	Sep. 11, 2016				
Pre-amplifier	HP	8447D	2727A05017	Sep. 11, 2016				
Loop antenna	ZHINAN	ZN30900A	12024	Sep. 13, 2016				
Broadband Antenna	Schwarzbeck	VULB9163	340	Sep. 13, 2016				
Horn Antenna	Schwarzbeck	BBHA 9120D	631	Sep. 13, 2016				
Horn Antenna	Schwarzbeck	BBHA 9170	373	Sep. 13, 2016				
Antenna Mast	CCS	CC-A-4M	N/A	N/A				
Coax cable	тст	RE-low-01	N/A	Sep. 11, 2016				
Coax cable	тст	RE-high-02	N/A	Sep. 11, 2016				
Coax cable	тст	RE-low-03	N/A	Sep. 11, 2016				
Coax cable	тст	RE-high-04	N/A	Sep. 11, 2016				
EMI Test Software	Shurple Technology	EZ-EMC	N/A	N/A				

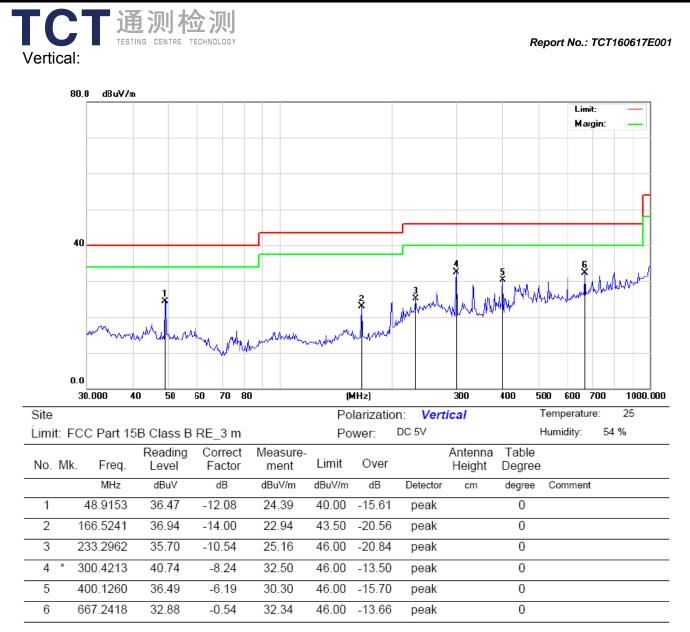
**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com



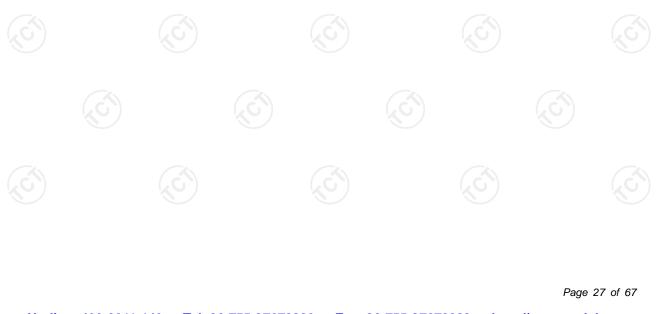
- Note:
  - 1. Worst case Duty cycle = on time/100 milliseconds = (2.908\*27+2.344)/100=0.8086
  - 2. Worst case Duty cycle correction factor = 20\*log (Duty cycle) = -1.85dB
  - 3. DH5 has the highest duty cycle worst case and is reported.
  - 4. The average levels were calculated from the peak level corrected with duty cycle correction factor (-1.85dB) derived from 20log (dwell time/100ms). This correction is only for signals that hop with the fundamental signal, such as band-edge and harmonic. Other spurious signals that are independent of the hopping signal would not use this correction.





**Note:** 1. The low frequency, which started from 9KHz~30MHz, was pre-scanned and the result which was 20dB lower than the limit line per 15.31(o) was not reported

2. Measurements were conducted in all three channels (high, middle, low) and three modulation (GFSK, Pi/4 DQPSK), and the worst case Mode (Lowest channel and GFSK) was submitted only.



#### Above 1GHz

Modulation	Type: GF	SK							
Low chann	el: 2402 N	IHz							
Frequency (MHz)	Ant. Pol. H/V	Peak reading (dBµV)	AV reading (dBuV)	Correction Factor (dB/m)	Peak	n Level AV (dBµV/m)	Peak limit (dBµV/m)	AV limit (dBµV/m)	Margin (dB)
2390	Н	44.08		-8.27	35.81		74	54	-18.19
4804	Н	44.35		0.66	45.01		74	54	-8.99
7206	Н	34.09		9.5	43.59		74	54	-10.41
	, GA		-4.6		()	<u> </u>		(-€)	
							•		
2390	V	43.81		-8.27	35.54		74	54	-18.46
4804	V	45.58		0.66	46.24		74	54	-7.76
7206	V	40.14		9.5	49.64		74	54	-4.36
0)	V	KO)		🤇	·)				

#### Middle channel: 2441 MHz

Frequency	Ant. Pol.	Peak	AV	Correction		on Level	Peak limit	AV limit	Margin
(MHz)	H/V	reading (dBµV)	reading (dBµV)	Factor (dB/m)	Peak (dBµV/m)	AV (dBµV/m)	(dBµV/m)	(dBµV/m)	(dB)
4882	Ŧ	41.54		0.99	42.53		74	54	-11.47
7323	Н	38.79		9.87	48.66		74	54	-5.34
	Н								
									( ć
4882	V	42.85		0.99	43.84		74	54	-10.16
7323	V	39.45		9.87	49.32		74	54	-4.68
	V								

#### High channel: 2480 MHz

nigh chan	IEI. 2400 IV			· )					
Frequency	Ant. Pol.	Peak	AV	Correction		on Level	Peak limit	AV limit	Margin
(MHz)	H/V	reading (dBµV)	reading (dBµV)	Factor (dB/m)	Peak (dBµV/m)	AV (dBµV/m)		(dBµV/m)	(dB)
2483.5	Н	45.79		-7.83	37.96		74	54	-16.04
4960	Н	47.81		1.33	49.14		74	54	-4.86
7440	Н	39.82		10.22	50.04		74	54	-3.96
	Н								
2483.5	V	47.95		-7.83	40.12	<u> </u>	74	54	-13.88
4960	GV	47.11	-40	1.33	48.44	$\mathcal{O}$	74	54	-5.56
7440	V	39.13		10.22	49.35		74	54	-4.65
	V								

#### Note:

1. Emission Level=Peak Reading + Correction Factor; Correction Factor= Antenna Factor + Cable loss - Pre-amplifier

2. Margin (dB) = Emission Level (Peak) (dB $\mu$ V/m)-Average limit (dB $\mu$ V/m)

3. The emission levels of other frequencies are very lower than the limit and not show in test report.

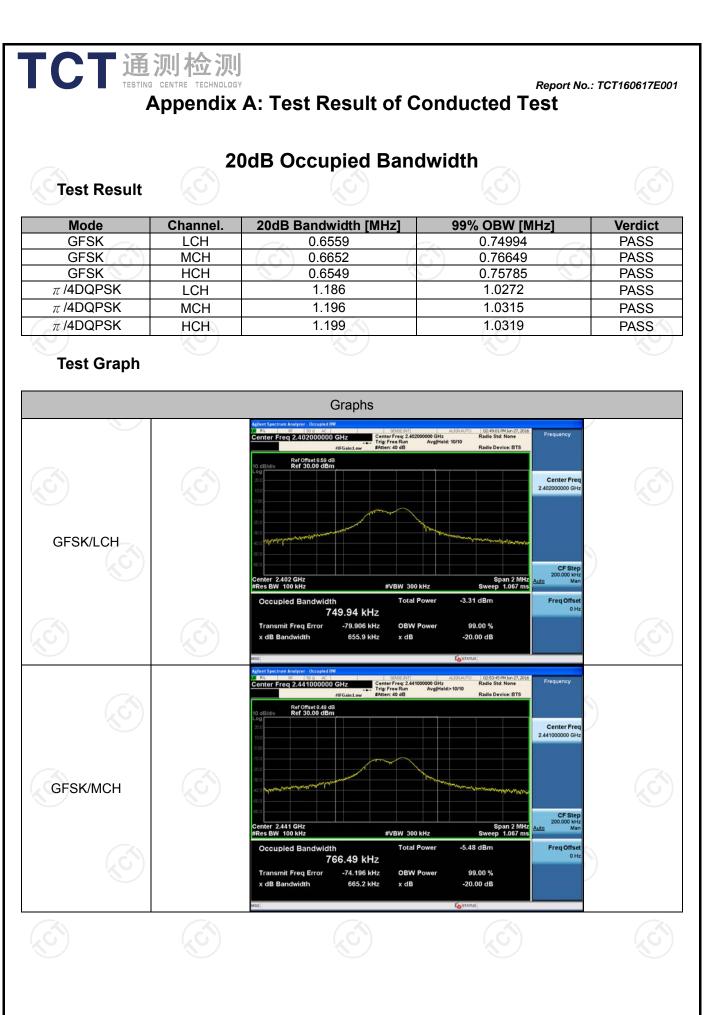
4. Measurements were conducted from 1 GHz to the 10th harmonic of highest fundamental frequency.

- 5. Data of measurement shown "----"in the above table mean that the reading of emissions is attenuated more than 20 dB below the limits or the field strength is too small to be measured.
- 6. Measurements were conducted in all three modulation (GFSK, Pi/4 DQPSK), and the worst case Mode (GFSK) was submitted only.

\*\*\*\*\*END OF REPORT\*\*\*\*\*

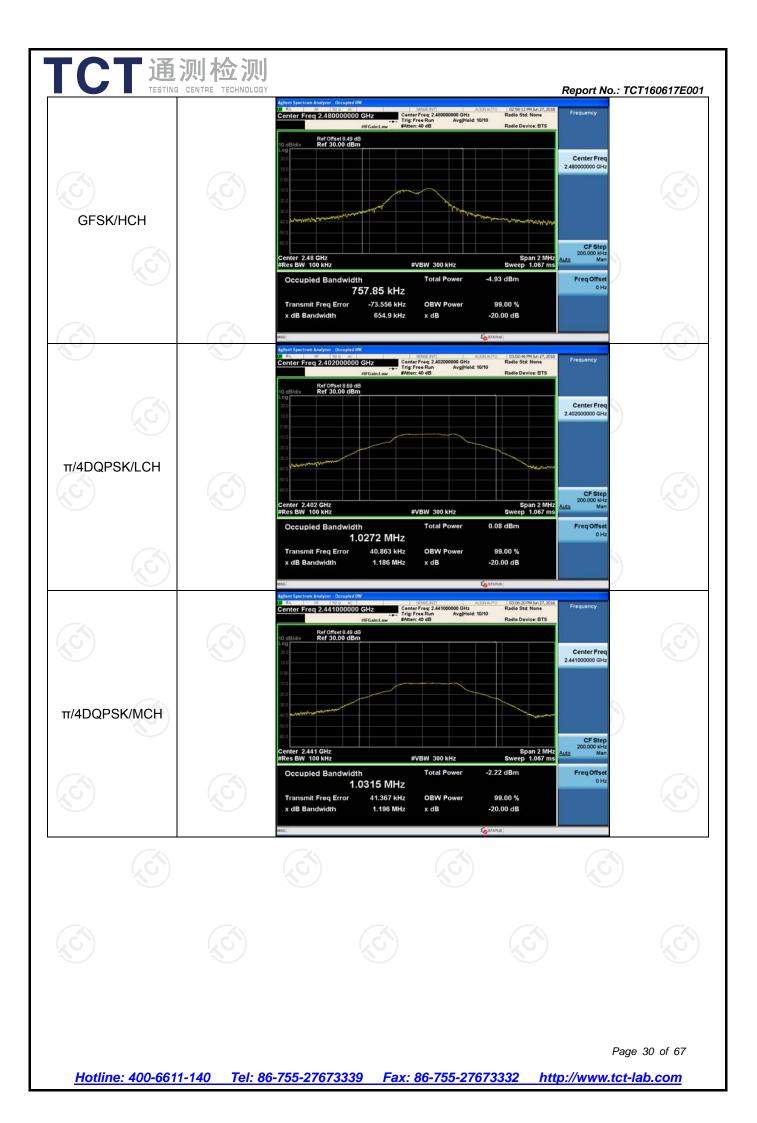


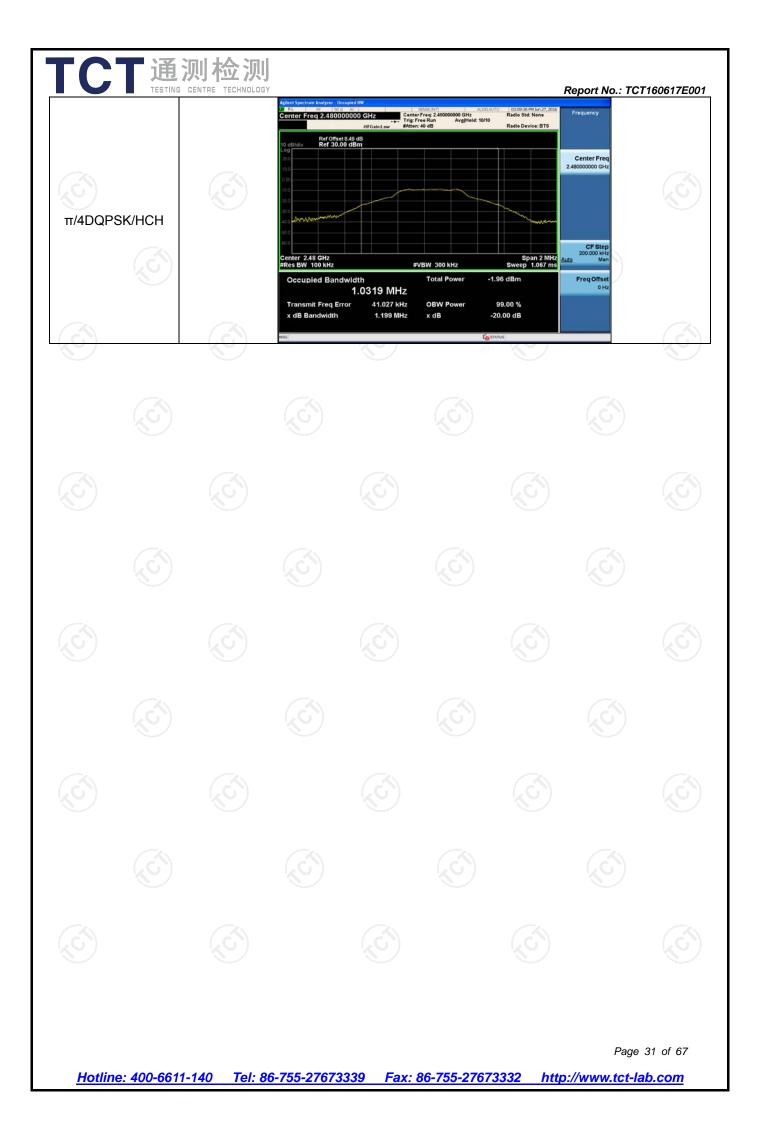
Page 28 of 67



Page 29 of 67

Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com







# **Carrier Frequency Separation**

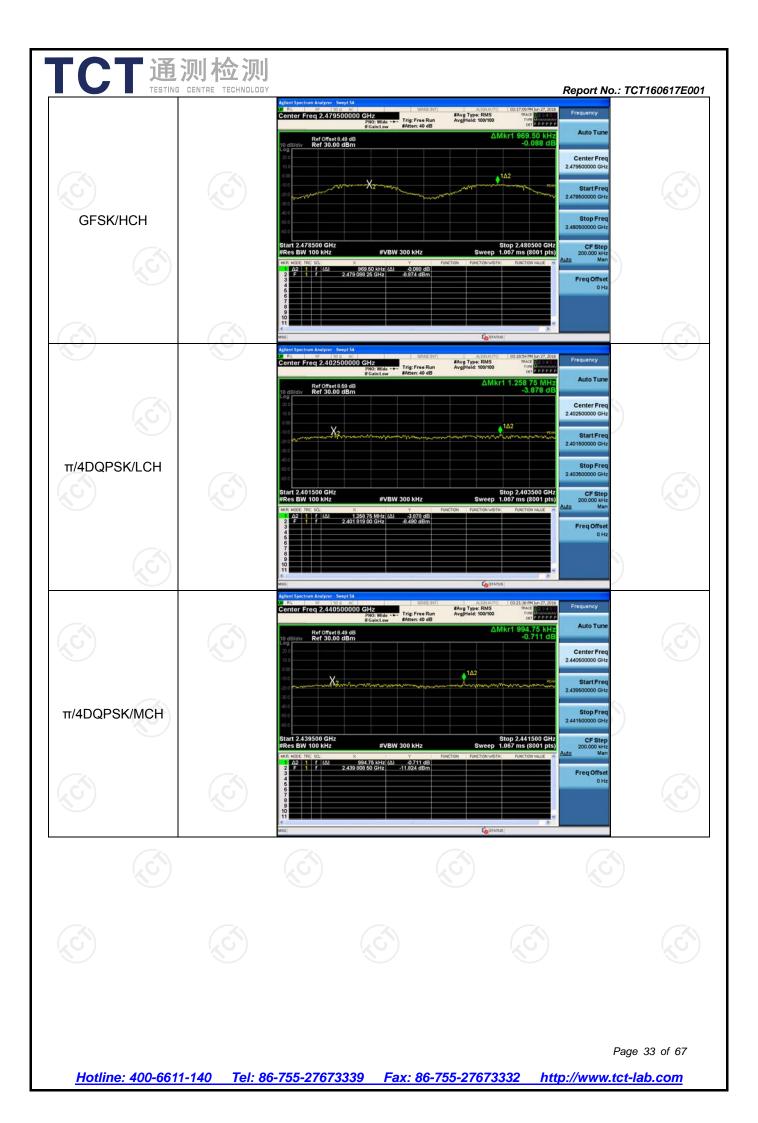
#### **Result Table**

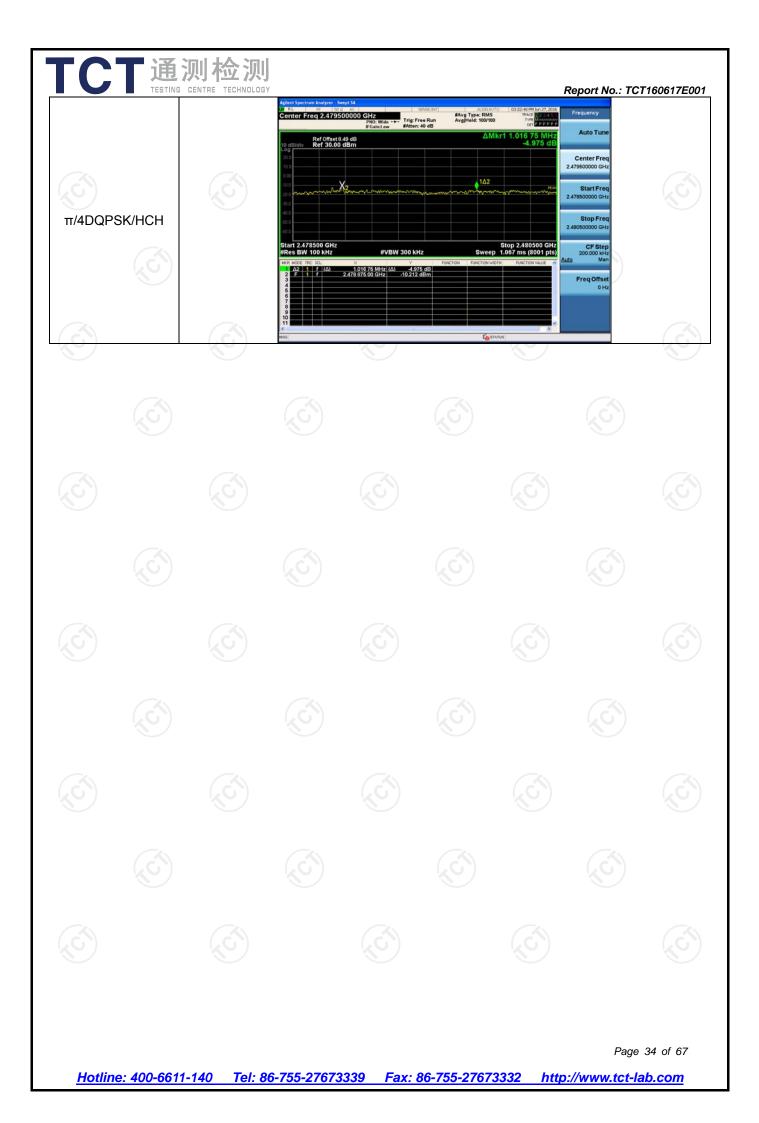
Mode	Channel.	Carrier Frequency Separation [MHz]	Verdict
GFSK	LCH	1.008	PASS
GFSK	MCH	0.931	PASS
GFSK	HCH	0.970	PASS
π/4DQPSK	LCH	1.259	PASS
π/4DQPSK	MCH	0.995	PASS
π/4DQPSK	HCH	1.017	PASS

#### Test Graph









# Dwell Time

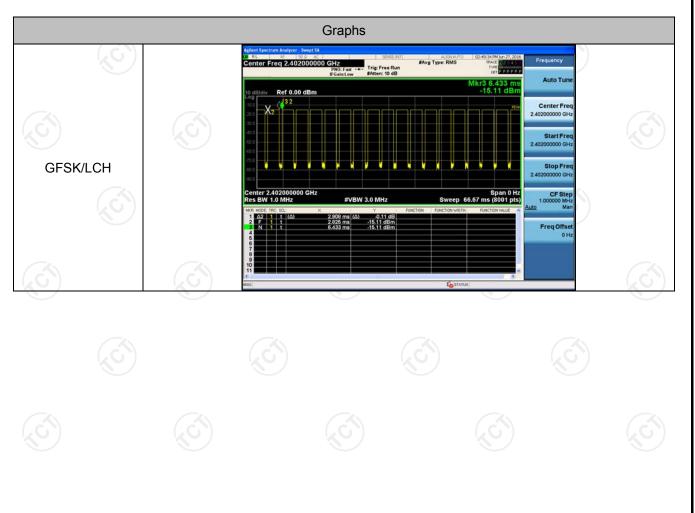
#### **Result Table**

The Dwell Time=Burst Width\*Total Hops. The detailed calculations are showed as follows:

- The duration for dwell time calculation:0.4[s]\*hopping number=0.4[s]\*79[ch]=31.6[s\*ch];
- The burst width [ms/hop/ch], which is directly measured, refers to the duration on one channel hop.
- The hops per second for all channels: The selected EUT Conf uses a slot type of 5-Tx&1-Rx and a hopping rate of 1600 [ch\*hop/s] for all channels. So the final hopping rate for all channels is 1600/6=266.67 [ch\*hop/s]
- The hops per second on one channel: 266.67 [ch\*hops/s]/79 [ch]=3.38 [hop/s];
- The total hops for all channels within the dwell time calculation duration:3.38 [hop/s]\*31.6[s\*ch]=106.67 [hop\*ch];
  - The dwell time for all channels hopping: 106.67 [hop\*ch]\*Burst Width [ms/hop/ch].

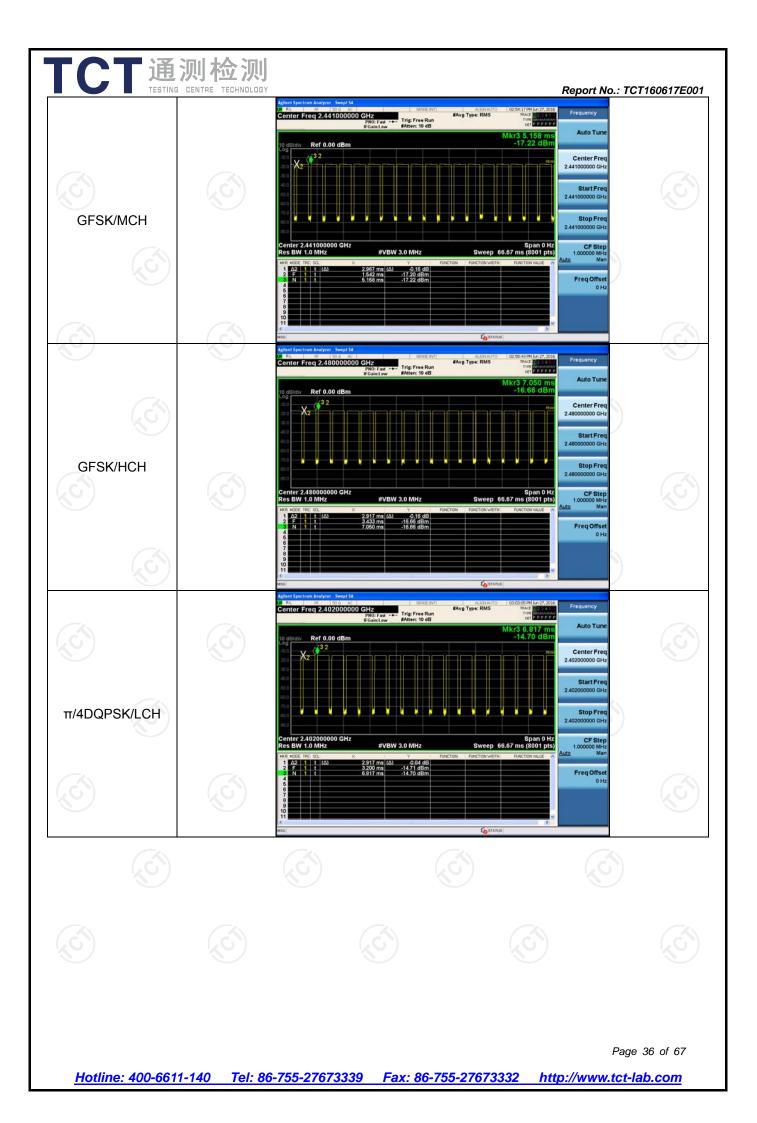
Mode	Channe I	Burst Width [ms/hop/ch]	Total Hops[hop*ch]	Dwell Time[s]	Duty Cycle [%]	Verdic t
GFSK	LCH	2.908	106.7	0.31	80.60	PASS
GFSK	MCH	2.967	106.7	0.317	82.03	PASS
GFSK	HCH	2.917	106.7	0.311	80.65	PASS
π/4DQPSK	LCH	2.917	106.7	0.311	80.65	PASS
π/4DQPSK	MCH	2.967	106.7	0.317	82.03	PASS
π/4DQPSK	HCH	2.908	106.7	0.31	80.60	PASS

# Test Graph

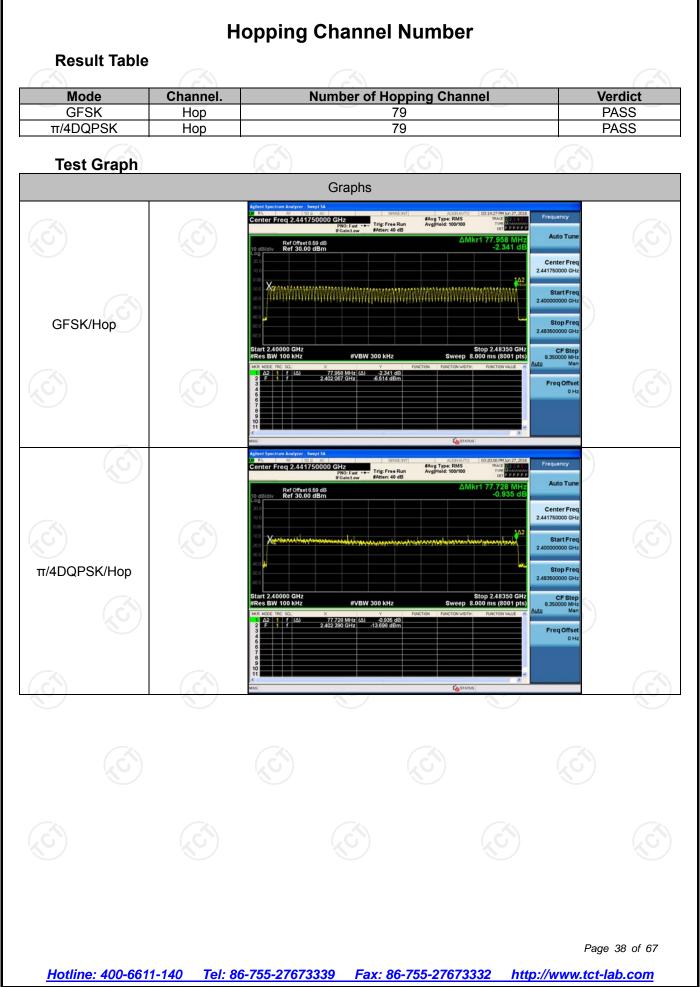


Page 35 of 67

Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com







|--|

Report No.: TCT160617E001

**Conducted Peak Output Power** 

Result Table			
Mode	Channel.	Maximum Peak Output Power [dBm]	Verdict
GFSK	LCH	-5.817	PASS
GFSK	MCH	-7.832	PASS
GFSK	HCH	-7.118	PASS
π/4DQPSK	LCH	-5.381	PASS
π/4DQPSK	MCH	-7.473	PASS
π/4DQPSK	HCH	-7.225	PASS

# **Test Graph**



Hotline: 400-6611-140 Tel: 86-755-27673339 Fax: 86-755-27673332 http://www.tct-lab.com

